

# H1M120Q060

Silicon Carbide MOSFET  
N-CHANNEL ENHANCEMENT MODE

## Features

- Low On-Resistance and High Current Density
- Low Capacitance for High Frequency Operation
- Positive Temperature Coefficient Device
- Low impedance Kelvin source pin-out
- AEC-Q101 Qualified
- RoHS Compliant and Halogen Free

## Benefits

- Higher System Efficiency
- Increase Parallel Device Convenience
- Capable of 175°C High  $T_j$  Application
- Allow High Frequency Operation
- Realize Compact and Lightweight Systems

## Applications

- Switching Mode Power Supply
- DC/DC Converters, UPS, and PFC
- EV Charging Station
- Motor Drives
- Power Inverters
- Solar/Wind Renewable Energy

## Absolute Maximum Ratings ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

| Parameter                      | Symbol               | Test Conditions   | Value      | Unit |
|--------------------------------|----------------------|---|------------|------|
| Drain – Source Voltage         | $V_{DS, \text{max}}$ | $V_{GS}=0\text{V}, I_{D\text{s}}=100\mu\text{A}$                  | 1200       | V    |
| Continuous Drain Current       | $I_D$                | $V_{GS}=20\text{V}, T_c=25^\circ\text{C}$                         | 44.5       | A    |
|                                |                      | $V_{GS}=20\text{V}, T_c=110^\circ\text{C}$                        | 30.6       |      |
|                                |                      | $t_{PW}$ limitation per Fig.15                                    | 90.5       |      |
| Avalanche energy, Single Pulse | $E_{AS}$             | $V_{DD}=100\text{V}, I_D=10\text{A}$                              | 1250       | mJ   |
| Power Dissipation              | $P_D$                | $T_c=25^\circ\text{C}$  | 250.0      | W    |
| Recommend Gate Source Voltage  | $V_{GS, \text{op}}$  | Static, recommended DC operating values                           | -5 to 20   | V    |
| Maximum Gate Source Voltage    | $V_{GS, \text{max}}$ | Transient operating limit (AC $f > 1\text{Hz}$ , duty cycle < 1%) | -10 to 25  |      |
| Junction & Storage Temperature | $T_j, T_{stg}$       |   | -55 to 175 | °C   |
| Soldering Temperature          | $T_L$                |   | 260        |      |
| Mounting Torque                | $M_D$                | M3 or 6-32 screw  | 1.0        | Nm   |

## Thermal Resistance

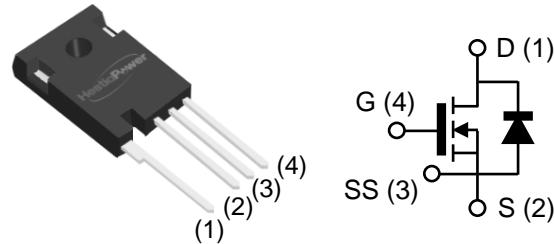
| Parameter                            | Symbol           | Min. | Typ. | Max. | Unit |
|--------------------------------------|------------------|------|------|------|------|
| Thermal Resistance, Junction to Case | $R_{\theta, JC}$ |      | 0.6  |      | °C/W |

## Product Summary

|                          |       |
|--------------------------|-------|
| $V_{DS}$                 | 1200V |
| $I_D(@25^\circ\text{C})$ | 44.5A |
| $R_{DS(\text{on})}$      | 60mΩ  |



## Circuit Diagram



| Part Number | Package   | Marking    |
|-------------|-----------|------------|
| H1M120Q060  | TO-247-4L | H1M120Q060 |

## Description

The H1M120Q060 1200V, 60mΩ silicon carbide power MOSFET is an N-channel enhancement mode device. Exploiting the outstanding wide bandgap material properties, this device shows high current density and great switching behavior. Thanks to the excellent thermal conductivity and many advantages of SiC, this device significantly improved in thermal capability and temperature independent switching behavior. With the high stability and reliability, this device also passes the qualification criteria based on AEC-Q101.

## Electrical Characteristics ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

| Parameter                                    | Symbol                      | Test Conditions   | Min. | Typ. | Max. | Unit |
|--|-----------------------------|---|------|------|------|------|
| Drain-Source Breakdown Voltage               | $V_{(\text{BR})\text{DSS}}$ | $V_{GS}=0\text{V}, I_{DS}=100\mu\text{A}$   | 1200 |      |      | V    |
| Gate Threshold Voltage                       | $V_{GS(\text{th})}$         | $V_{DS}=10\text{V}, I_{DS}=20\text{mA}$   |      | 2.85 |      | V    |
| Zero Gate Voltage Drain Current              | $I_{\text{DSS}}$            | $V_{DS}=1200\text{V}, V_{GS}=0\text{V}$<br>$V_{DS}=1200\text{V}, V_{GS}=0\text{V}$<br>$T_j=175^\circ\text{C}$ | <1   | 50   |      |      |
| Gate-Source Leakage Current                  | $I_{GSS}$                   | $V_{GS}=20\text{V}, V_{DS}=0\text{V}$   |      | 250  |      | nA   |
| Drain-Source On-State Resistance             | $R_{\text{DS}(\text{on})}$  | $V_{GS}=20\text{V}, I_{DS}=20\text{A}$<br>$V_{GS}=20\text{V}, I_{DS}=20\text{A},$<br>$T_j=175^\circ\text{C}$  | 60   | 80   |      | mΩ   |
| Transconductance                             | $g_{fs}$                    | $V_{DS}=12.5\text{V}, I_{DS}=40\text{A}$  | 10.5 |      |      | S    |
| Input Capacitance                            | $C_{iss}$                   |   | 2200 |      |      |      |
| Output Capacitance                           | $C_{oss}$                   | $V_{GS}=0\text{V}, V_{DS}=800\text{V}$<br>$f=1\text{MHz}, V_{AC}=25\text{mV}$                                 | 115  |      |      |      |
| Reverse Transfer Capacitance                 | $C_{rss}$                   |   | 18.5 |      |      |      |
| Effective Output Capacitance, Energy Related | $C_{o(er)}$                 | $V_{GS}=0\text{V},$<br>$V_{DS}=0 \text{ to } 800\text{V}$   | 150  |      |      | pF   |
| Effective Output Capacitance, Time Related   | $C_{o(tr)}$                 | $I_D=\text{const.}, V_{GS}=0\text{V},$<br>$V_{DS}=0 \text{ to } 800\text{V}$                                  | 211  |      |      |      |
| Turn On Delay Time                           | $t_{d(on)}$                 |   | 25   |      |      |      |
| Rise Time                                    | $t_r$                       |   | 24   |      |      |      |
| Turn Off Delay Time                          | $t_{d(off)}$                |   | 20   |      |      |      |
| Fall Time                                    | $t_f$                       |   | 9    |      |      |      |
| $C_{oss}$ Stored Energy                      | $E_{oss}$                   | $V_{GS}=0\text{V}, V_{DS}=800\text{V}$<br>$f=1\text{MHz}, V_{AC}=25\text{mV}$                                 | 47   |      |      |      |
| Turn-on Switching Energy                     | $E_{on}$                    | $V_{DS}=800\text{V}, V_{GS}=0/20\text{V},$<br>$I_D=20\text{A},$<br>$R_{G(\text{ext})}=2.7 \Omega$             | 63*  |      |      | μJ   |
| Turn-off Switching Energy                    | $E_{off}$                   | $R_{G(\text{ext})}=2.7 \Omega$  | 69*  |      |      |      |
| Internal Gate Resistance                     | $R_{G(\text{int.})}$        | $f=1\text{MHz}, V_{AC}=25\text{mV}$   | 1.2  |      |      | Ω    |

## Built-in SiC Diode Characteristics ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

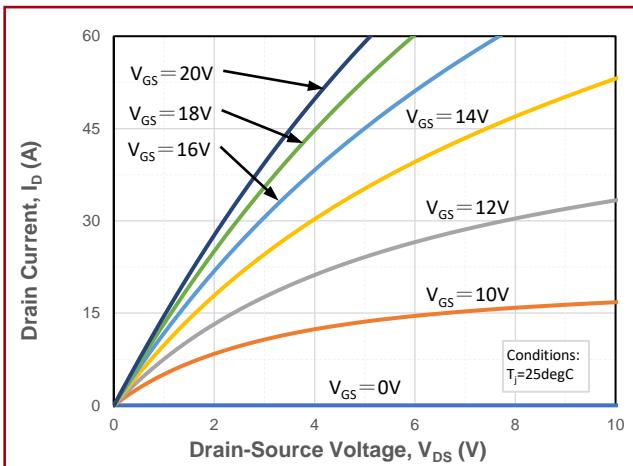
| Parameter                        | Symbol    | Test Conditions   | Typ. | Unit |
|----------------------------------|-----------|---|------|------|
| Inverse Diode Forward Voltage    | $V_{SD}$  | $V_{GS}=0\text{V}, I_{SD}=5\text{A}$  | 2.65 | V    |
| Continuous Diode Forward Current | $I_s$     | $V_{GS}=0\text{V}, T_c=25^\circ\text{C}$                                    | 44   | A    |
| Reverse Recovery Time            | $t_{rr}$  | $V_{GS}=0\text{V},$   | 57   | ns   |
| Reverse Recovery Charge          | $Q_{rr}$  | $I_{SD}=20\text{A}, V_{DS}=400\text{V},$<br>$di/dt=300\text{A}/\mu\text{s}$ | 109  | nC   |
| Peak Reverse Recovery Current    | $I_{rrm}$ |   | 3.5  | A    |

\*Based on the results of calculation, note that the energy loss caused by the reverse recovery of free-wheeling diode is not included in  $E_{on}$ .

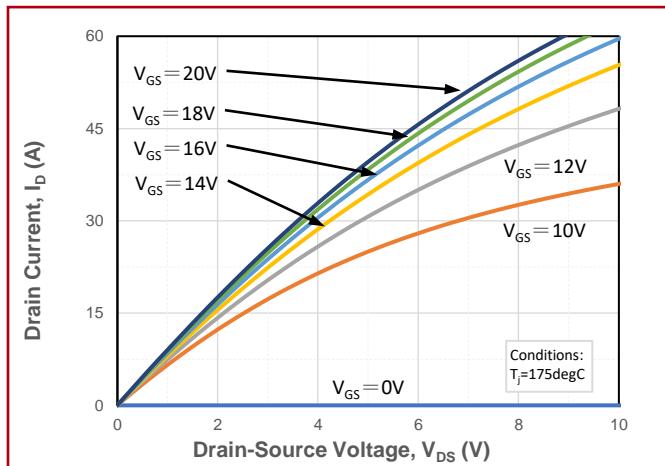
## Gate Charge Characteristics ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

| Parameter             | Symbol   | Test Conditions | Value | Unit |
|-----------------------|----------|-----------------|-------|------|
| Gate to Source Charge | $Q_{GS}$ |                 | 29    |      |
| Gate to Drain Charge  | $Q_{GD}$ |                 | 64    | nC   |
| Total Gate Charge     | $Q_G$    |                 | 129   |      |
| Gate plateau voltage  | $V_{pl}$ |                 | 6.95  | V    |

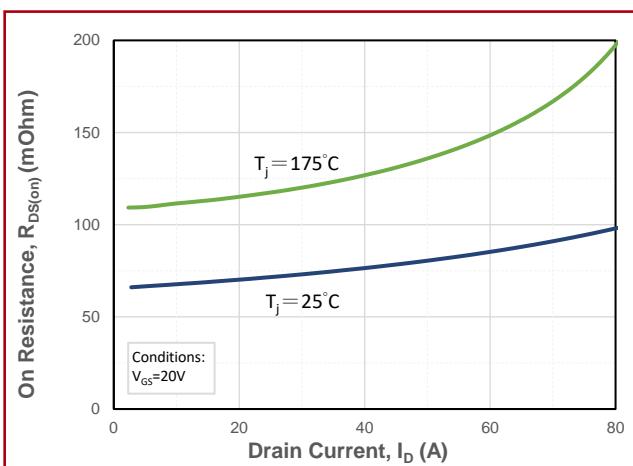
## Typical Device Performance



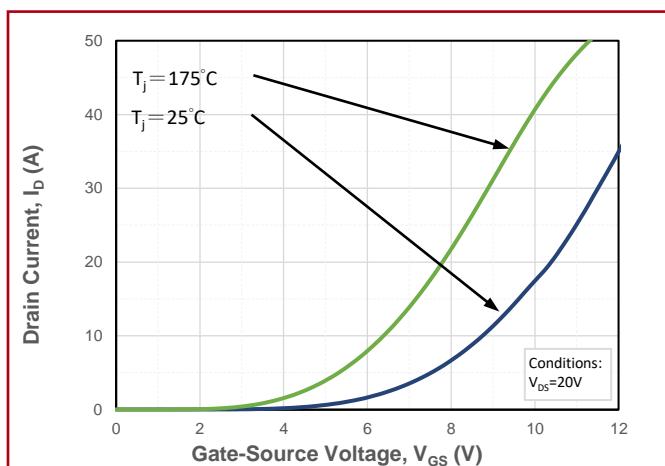
**Fig.1** Forward Output Characteristics at  $T_j=25^\circ\text{C}$



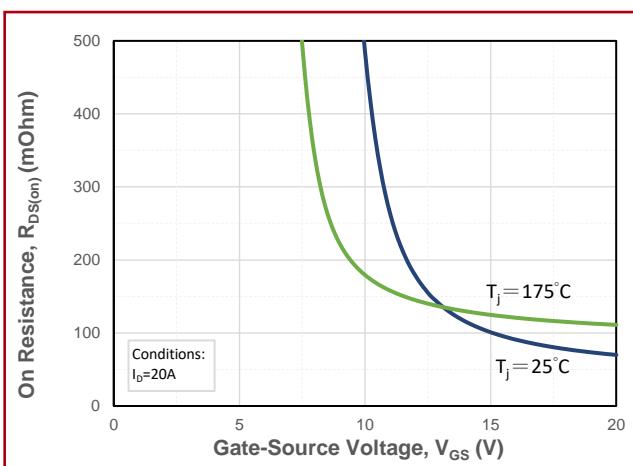
**Fig.2** Forward Output Characteristics at  $T_j=175^\circ\text{C}$



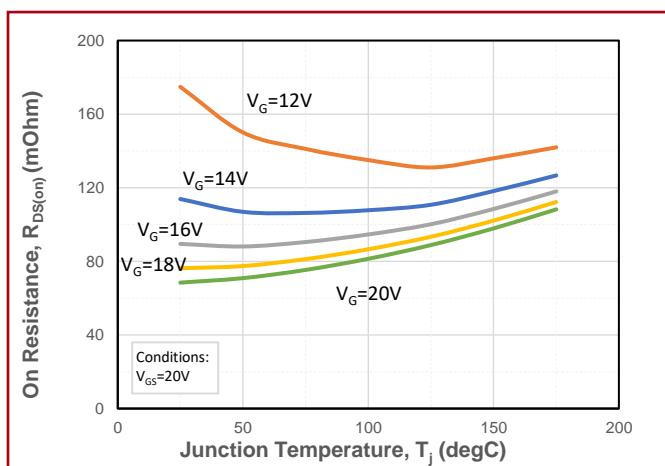
**Fig.3** On-Resistance vs. Drain Current for Various  $T_j$



**Fig.4** Transfer Characteristics for Various  $T_j$

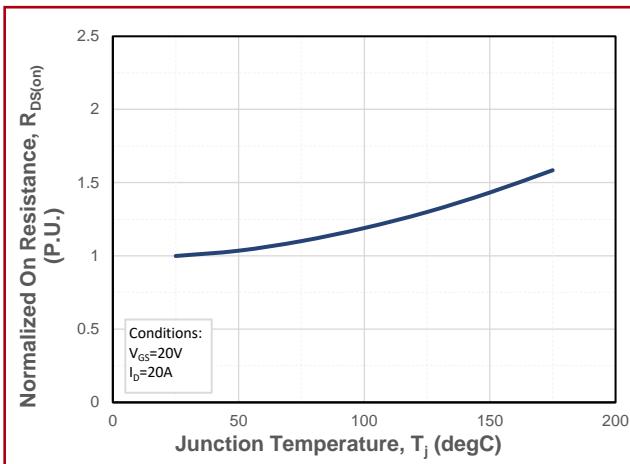


**Fig.5** On-Resistance vs. Gate Voltage for Various  $T_j$

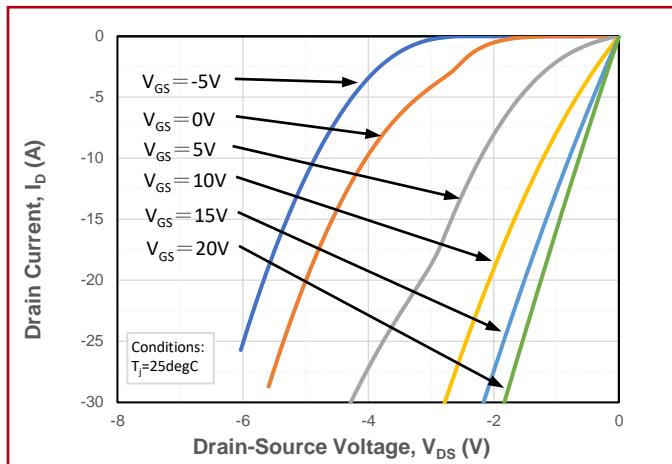


**Fig.6** On-Resistance vs. Temperature for Various Gate Voltage

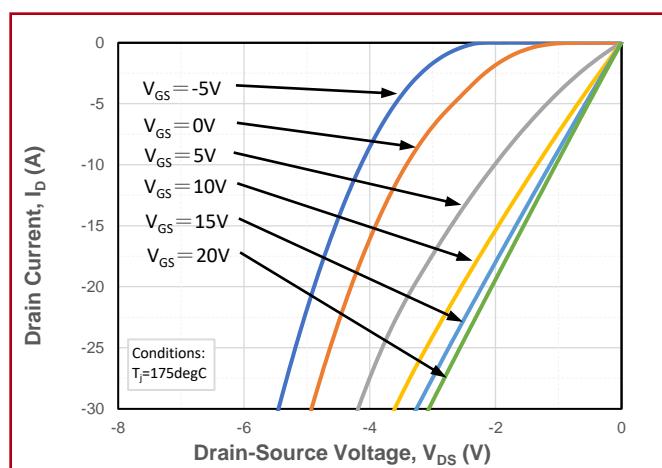
## Typical Device Performance



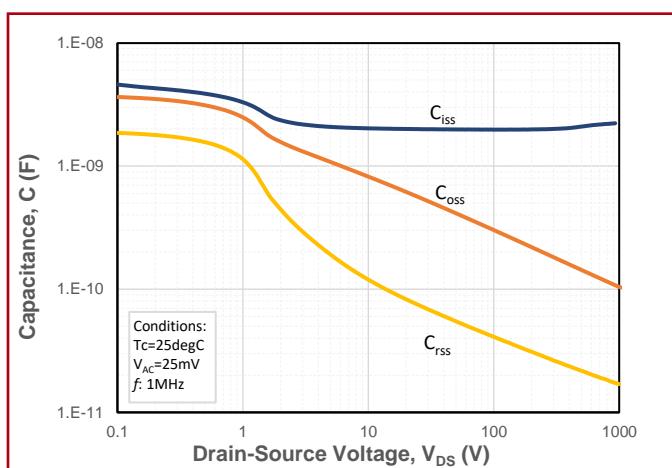
**Fig.7** Normalized On-Resistance vs. Temperature



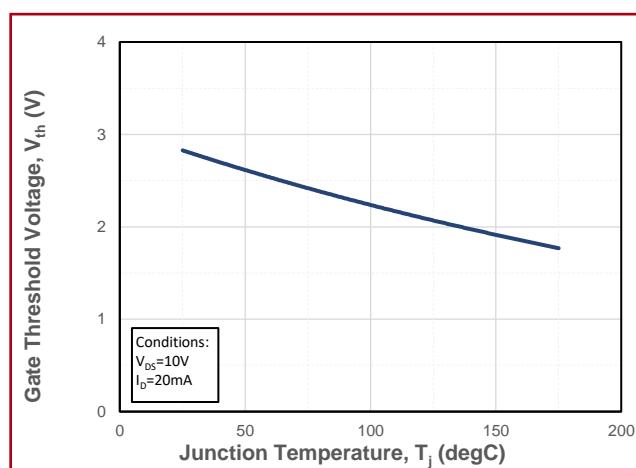
**Fig.8** Reverse Output Characteristics at  $T_j = 25^\circ\text{C}$



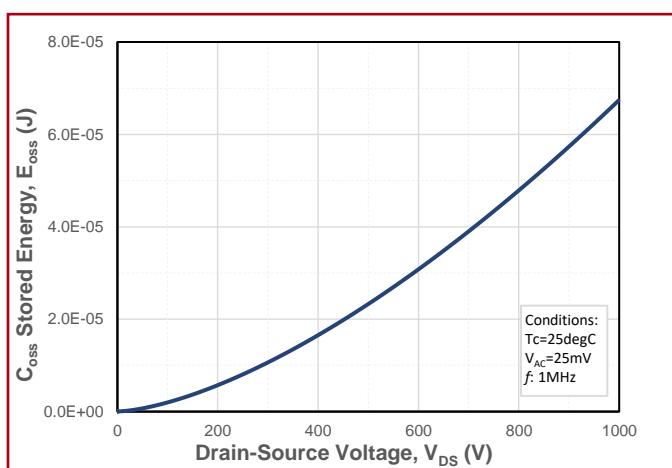
**Fig.9** Reverse Output Characteristics at  $T_j = 175^\circ\text{C}$



**Fig.10** Capacitances vs. Drain to Source Voltage



**Fig.11** Threshold Voltage vs. Temperature



**Fig.12** Output Capacitor Stored Energy

## Typical Device Performance

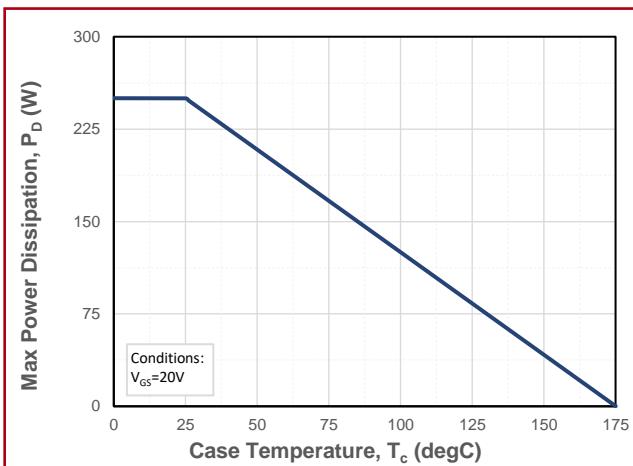


Fig.13 Maximum Power Dissipation Derating vs. Case Temperature

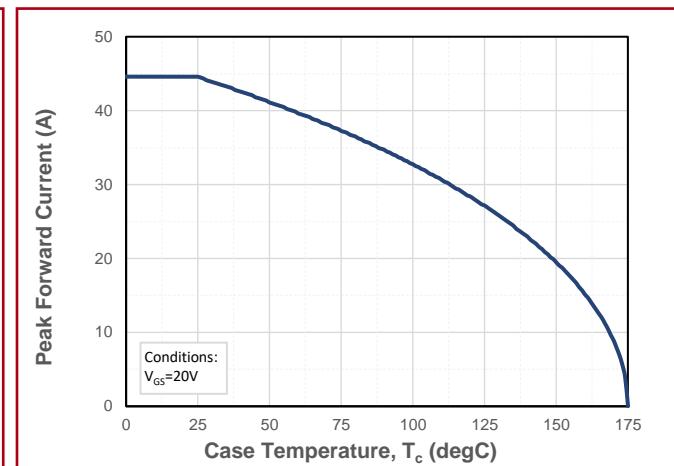


Fig.14 Drain Current Derating vs. Case Temperature

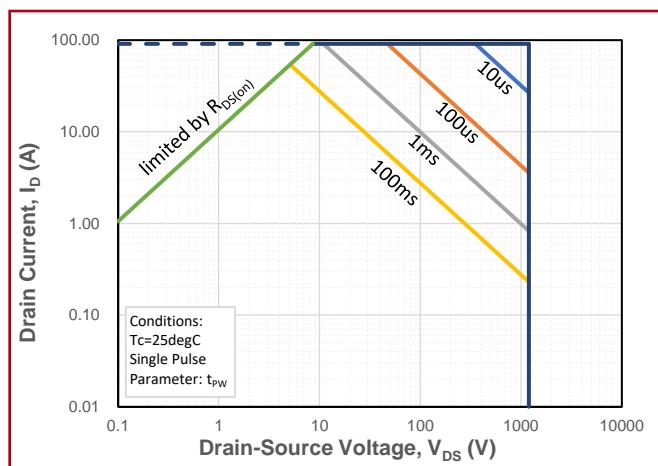


Fig.15 Safe Operating Area

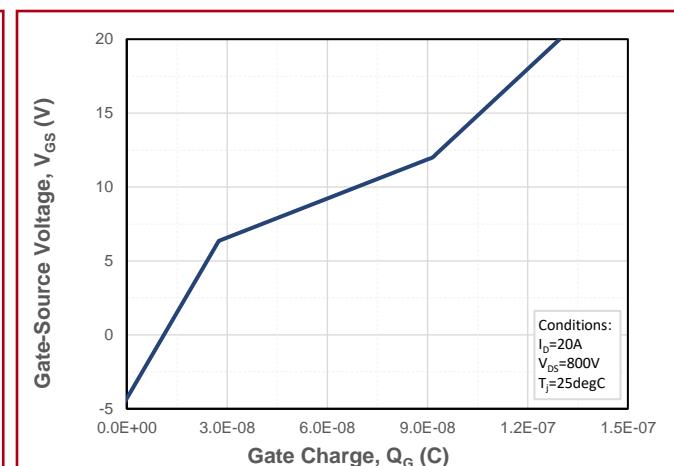


Fig.16 Gate Charge Characteristics

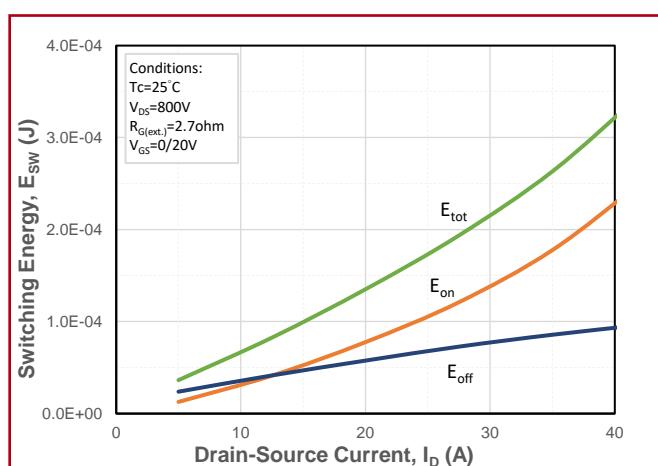


Fig.17 Clamped Inductive Switching Energy vs. Drain Current

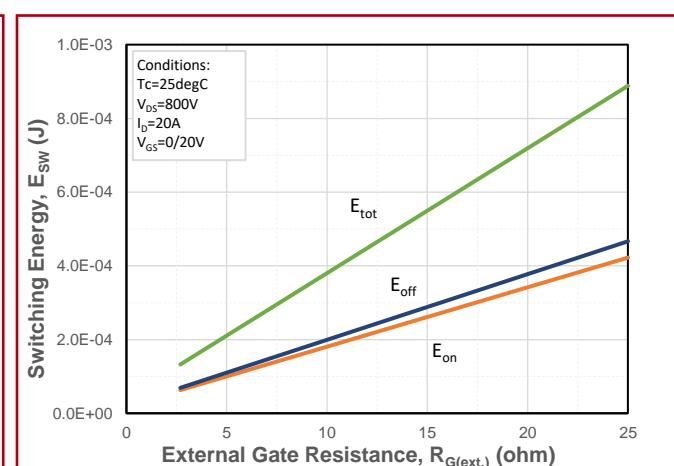


Fig.18 Clamped Inductive Switching Energy vs. External Gate Resistor ( $R_{G(ext)}$ )

## Typical Device Performance

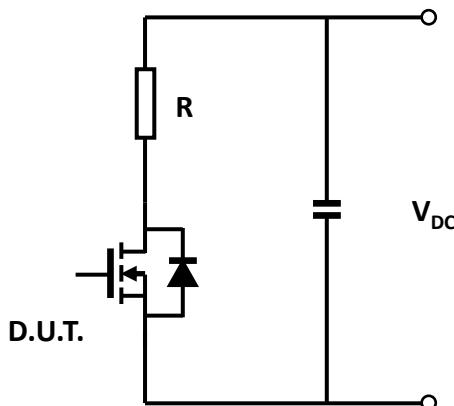


Fig.19 Schematic of Resistive Switching

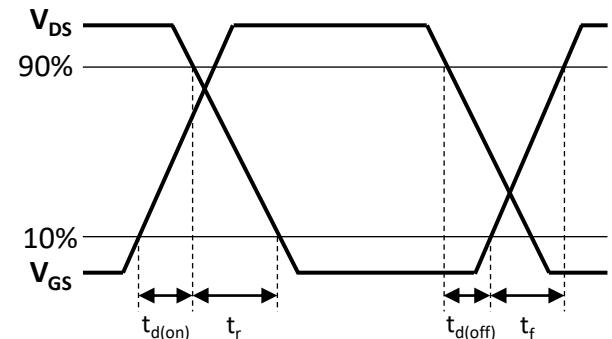


Fig.20 Switching Times Definition

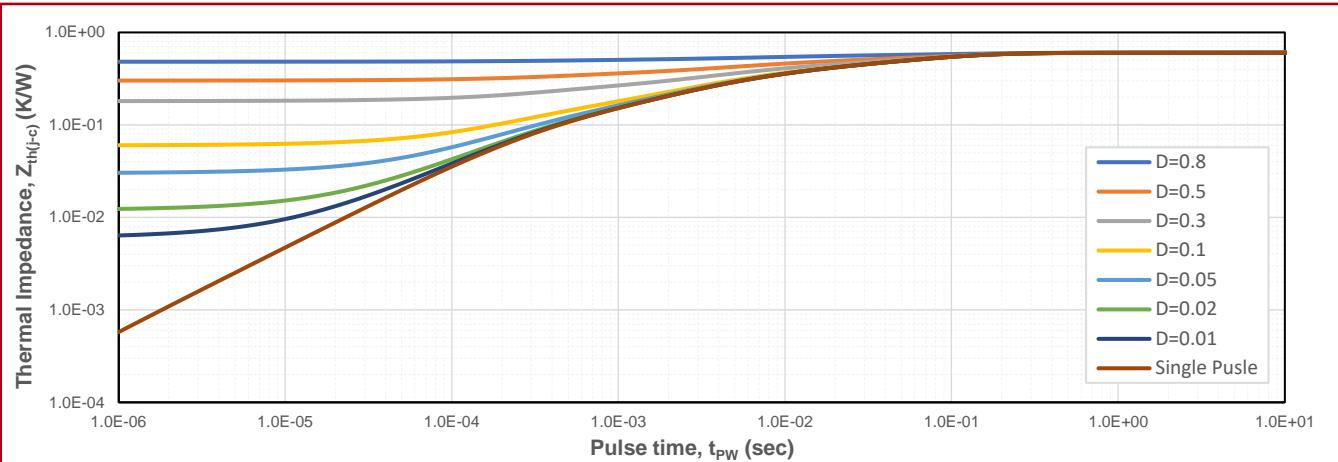
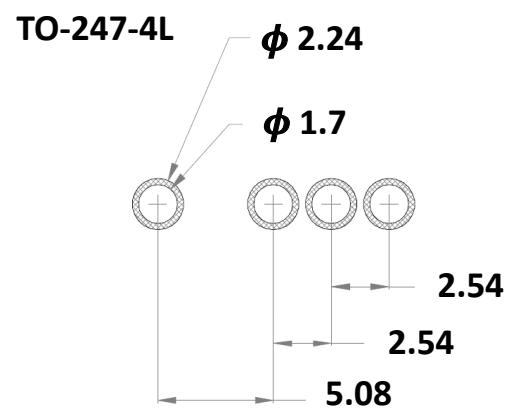


Fig.21 Transient Junction to Case Thermal Impedance

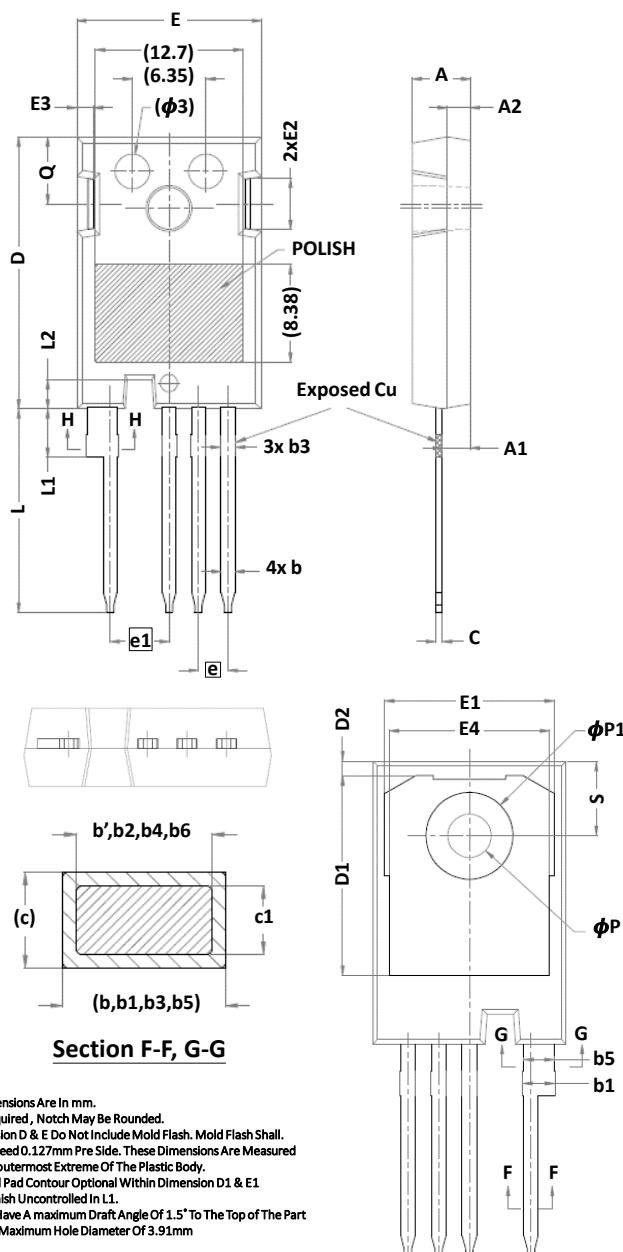
## Naming Rule

| H1 M 120 Q 060               |   |
|------------------------------|---|
| <b>Generation</b>            | H1 = 1 <sup>st</sup> Gen Discrete                             |
| <b>Device Type</b>           | M = MOSFET   J = JMOS<br>S = JBS diode                        |
| <b>Breakdown Voltage</b>     | 065 = 650V   170 = 1700V<br>120 = 1200V   330 = 3300V         |
| <b>Package</b>               | Q = TO-247-4L   B = TO-220-3L<br>T = TO-263-2L   N = Bare Die |
| <b>Typical On-Resistance</b> | 030 = 30mΩ   060 = 60mΩ   120 = 120mΩ<br>240 = 240mΩ          |

## Recommended Solder Pad Layout



## Package Dimensions



**Note:**  
 1. All Dimensions Are In mm.  
 2. Slot Required, Notch May Be Rounded.  
 3. Dimension D & E Do Not Include Mold Flash, Mold Flash Shall Not Exceed 0.127mm Per Side. These Dimensions Are Measured At The outermost Extreme Of The Plastic Body.  
 4. Thermal Pad Contour Optional Within Dimension D1 & E1.  
 5. Lead Finish Uncontrolled In L1.  
 6.  $\phi P$  To Have A maximum Draft Angle Of 1.5° To The Top Of The Part With A Maximum Hole Diameter Of 3.91mm

| Symbol    | mm        |       |       |
|-----------|-----------|-------|-------|
|           | Min.      | Typ.  | Max.  |
| A         | 4.83      | 5.02  | 5.21  |
| A1        | 2.29      | 2.41  | 2.54  |
| A2        | 1.91      | 2.00  | 2.16  |
| b'        | 1.07      | 1.20  | 1.28  |
| b         | 1.07      | 1.20  | 1.33  |
| b1        | 2.39      | 2.67  | 2.94  |
| b2        | 2.39      | 2.67  | 2.84  |
| b3        | 1.07      | 1.30  | 1.60  |
| b4        | 1.07      | 1.30  | 1.50  |
| b5        | 2.39      | 2.53  | 2.69  |
| b6        | 2.39      | 2.53  | 2.64  |
| c         | 0.55      | 0.60  | 0.68  |
| c1        | 0.55      | 0.60  | 0.65  |
| D         | 23.30     | 23.45 | 23.60 |
| D1        | 16.25     | 16.55 | 17.65 |
| D2        | 0.95      | 1.19  | 1.25  |
| E         | 15.75     | 15.94 | 16.13 |
| E1        | 13.10     | 14.02 | 14.15 |
| E2        | 3.68      | 4.40  | 5.10  |
| E3        | 1.00      | 1.45  | 1.90  |
| E4        | 12.38     | 13.26 | 13.43 |
| e         | 2.54 BSC  |       |       |
| e1        | 5.08 BSC  |       |       |
| L         | 17.31     | 17.57 | 17.82 |
| L1        | 3.97      | 4.19  | 4.37  |
| L2        | 2.35      | 2.50  | 2.65  |
| $\phi P$  | 3.51      | 3.61  | 3.65  |
| $\phi P1$ | 7.19 REF. |       |       |
| Q         | 5.49      | 5.79  | 6.00  |
| S         | 6.04      | 6.17  | 6.30  |

## Notes

- The information provided herein is subject to change without notice.
- For other information that does not show on this datasheet, please contact us for inquiry.